

<b>Notice of References Cited</b>	Application/Control No. 10/759,834		Applicant(s)/Patent Under Reexamination CHEN, CHUN-CHEN	
	Examiner Jean F. Duverne		Art Unit 2839	Page 1 of 1

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*	C	US-6,086,395 A	07-2000	Lloyd et al.	439/172
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**NON-PATENT DOCUMENTS**

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